

# NYC0102BLT1G

## Sensitive Gate Silicon Controlled Rectifiers Reverse Blocking Thyristors

Designed and tested for highly-sensitive triggering in low-power switching applications.

### Features

- High dv/dt
- Gating Current < 200  $\mu$ A
- Miniature SOT-23 Package for High Density PCB
- This is a Halogen-Free Device
- This is a Pb-Free Device

### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (R <sub>GK</sub> = 1K, T <sub>J</sub> = -40 to +110°C, Sine Wave, 50 to 60 Hz)	V <sub>DRM</sub> , V <sub>RRM</sub>	200	V
On-State Current RMS (180° Conduction Angle, T <sub>C</sub> = 80°C)	I <sub>T(RMS)</sub>	0.25	A
Peak Non-repetitive Surge Current, T <sub>A</sub> = 25°C, (1/2 Cycle, Sine Wave, 60 Hz)	I <sub>TSM</sub>	7.0	A
Circuit Fusing Considerations (t = 8.3 ms)	I <sup>2</sup> t	0.2	A <sup>2</sup> s
Forward Peak Gate Power (Pulse Width ≤ 1.0 $\mu$ sec, T <sub>A</sub> = 25°C)	P <sub>GM</sub>	0.1	W
Forward Average Gate Power (t = 8.3 msec, T <sub>A</sub> = 25°C)	P <sub>G(AV)</sub>	0.02	W
Forward Peak Gate Current (Pulse Width ≤ 20 $\mu$ s, T <sub>A</sub> = 25°C)	I <sub>FGM</sub>	0.5	A
Reverse Peak Gate Voltage (Pulse Width ≤ 1.0 $\mu$ s, T <sub>A</sub> = 25°C)	V <sub>RGM</sub>	8.0	V
Operating Junction Temperature Range @ Rated V <sub>RRM</sub> and V <sub>DRM</sub>	T <sub>J</sub>	-40 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-40 to +150	°C

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR-5 Board T <sub>A</sub> = 25°C	P <sub>D</sub>	225	mW
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	380	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

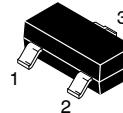
1. V<sub>DRM</sub> and V<sub>RRM</sub> for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.



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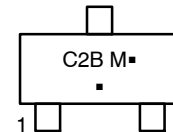
<http://onsemi.com>

## 0.25 AMP, 200 VOLT SCRs



SOT-23  
CASE 318  
STYLE 8

### MARKING DIAGRAM



C2B = Specific Device Code  
M = Date Code\*  
▪ = Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation and/or overbar may vary depending upon manufacturing location.

### PIN ASSIGNMENT

1	Cathode
2	Gate
3	Anode

### ORDERING INFORMATION

Device	Package	Shipping†
NYC0102BLT1G	SOT-23 (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# NYC0102BLT1G

## ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted.)

Characteristic	Symbol	Min	Typ	Max	Unit
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### OFF CHARACTERISTICS

Peak Repetitive Forward Blocking Current (V <sub>DRM</sub> = 200 V, R <sub>GK</sub> = 1 kΩ)	I <sub>DRM</sub>	T <sub>C</sub> = 25°C	-	-	1.0	μA
		T <sub>C</sub> = 125°C	-	-	100	μA
Peak Repetitive Reverse Blocking Current (V <sub>DRM</sub> = 200 V, R <sub>GK</sub> = 1 kΩ)	I <sub>RRM</sub>	T <sub>C</sub> = 25°C	-	-	1.0	μA
		T <sub>C</sub> = 125°C	-	-	100	μA

### ON CHARACTERISTICS

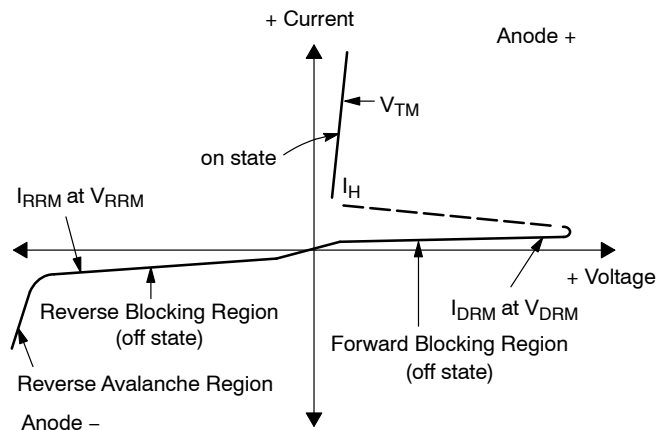
Peak Forward On-State Voltage (I <sub>TM</sub> = 0.4 A, t <sub>p</sub> < 1 ms, T <sub>C</sub> = 25°C)	V <sub>TM</sub>	-	-	1.7	V
Gate Trigger Current (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ω, T <sub>C</sub> = 25°C)	I <sub>GT</sub>	-	-	200	μA
Gate Trigger Voltage (V <sub>D</sub> = 12 V, R <sub>L</sub> = 100 Ω, T <sub>C</sub> = 25°C)	V <sub>GT</sub>	-	-	0.8	V
Holding Current (I <sub>T</sub> = 50 mA, R <sub>GK</sub> = 1 kΩ, T <sub>C</sub> = 25°C)	I <sub>H</sub>	-	-	6.0	mA
Gate Non-Trigger Voltage (V <sub>D</sub> = V <sub>DRM</sub> , R <sub>L</sub> = 3.3 kΩ, T <sub>C</sub> = 125°C)	V <sub>GD</sub>	0.1	-	-	V
Latching Current (I <sub>G</sub> = 1.0 mA, R <sub>GK</sub> = 1 kΩ, T <sub>C</sub> = 25°C)	I <sub>L</sub>	-	-	7.0	mA
Gate Reverse Voltage (I <sub>RG</sub> = 10 μA)	V <sub>RG</sub>	8.0	-	-	V

### DYNAMIC CHARACTERISTICS

Critical Rate of Rise of Off-State Voltage (R <sub>GK</sub> = 1 kΩ, T <sub>C</sub> = 125°C)	dv/dt	200	-	-	V/μs
Critical Rate of Rise of On-State Current (I <sub>G</sub> = 2xI <sub>GT</sub> 60 Hz, t <sub>r</sub> < 100 ns, T <sub>J</sub> = 125°C)	di/dt	-	-	50	A/μs

## Voltage Current Characteristic of SCR

Symbol	Parameter
V <sub>DRM</sub>	Peak Repetitive Off State Forward Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
V <sub>RRM</sub>	Peak Repetitive Off State Reverse Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
V <sub>TM</sub>	Peak on State Voltage
I <sub>H</sub>	Holding Current



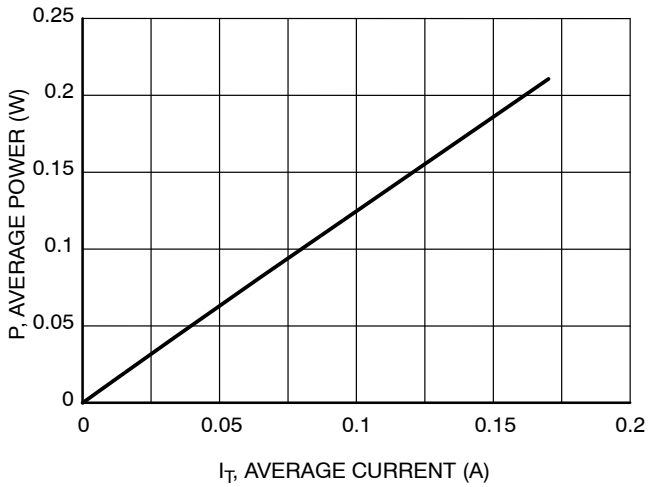


Figure 1. Maximum Average Power vs. Average Current

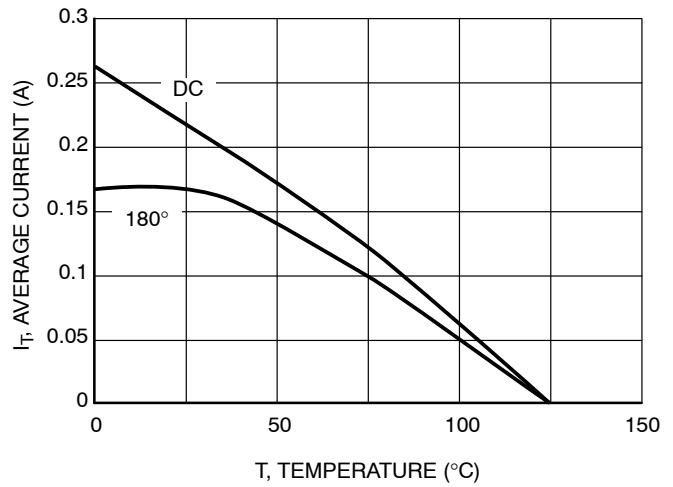


Figure 2. Current Derating

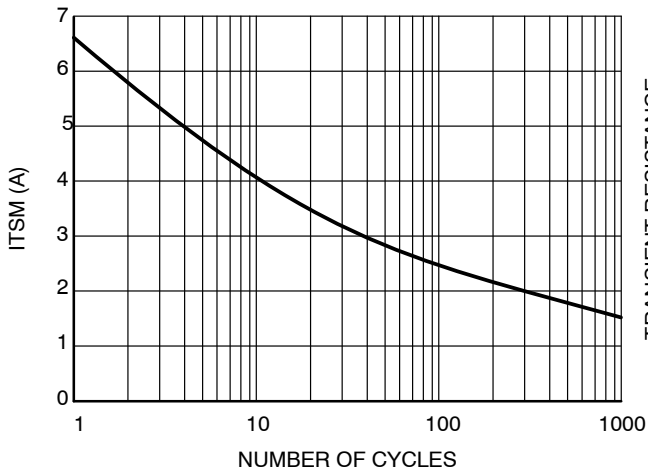


Figure 3. Surge Current ITSM vs. Number of Cycles

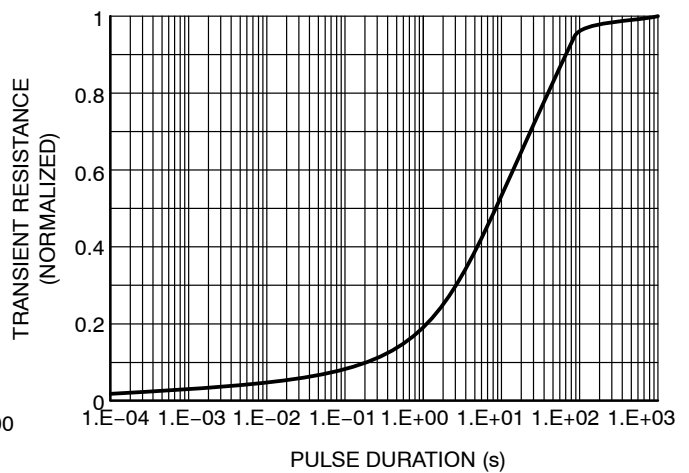


Figure 4. Thermal Response

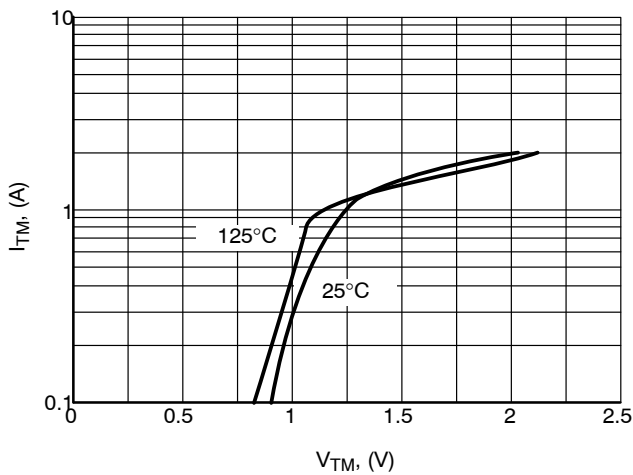


Figure 5. ON-State Characteristics

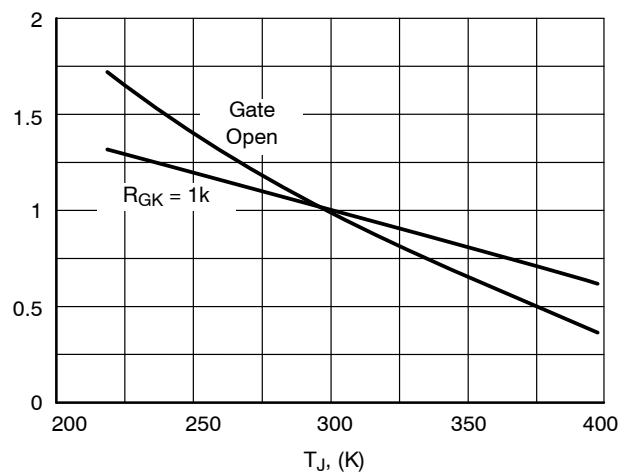


Figure 6. Gate Trigger Current vs.  $T_J$  (Normalized to 25°C)

NYC0102BLT1G

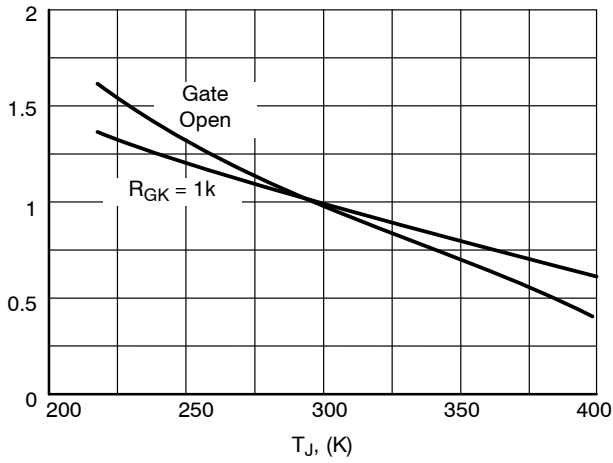


Figure 7. Gate Trigger Current vs.  $T_J$   
(Normalized to 25°C)

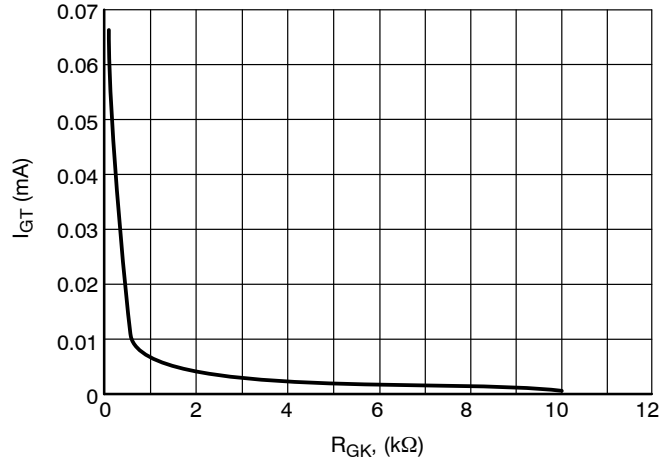


Figure 8. Gate Trigger Current vs.  $R_{GK}$

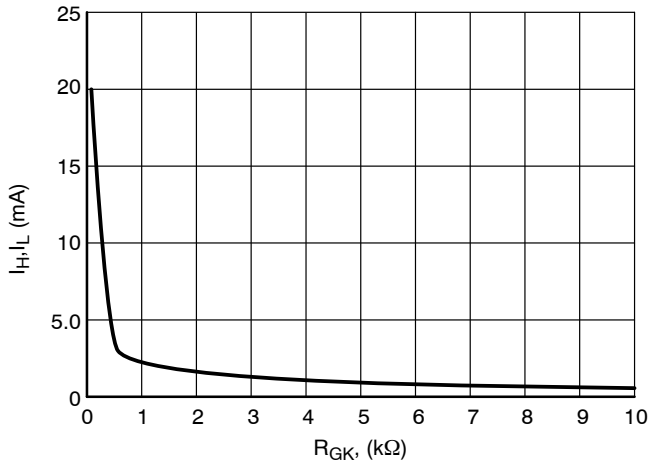


Figure 9. Holding and Latching Current vs.  $R_{GK}$

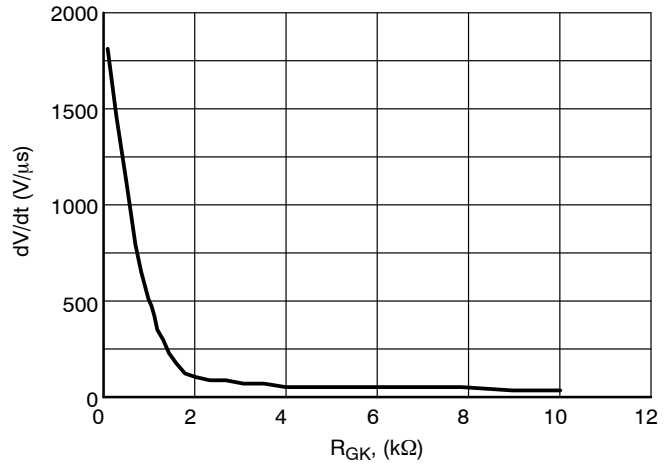


Figure 10. dV/dt vs.  $R_{GK}$

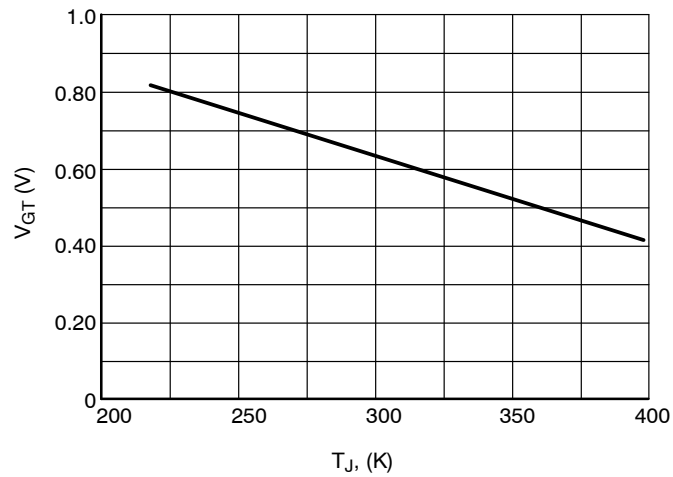
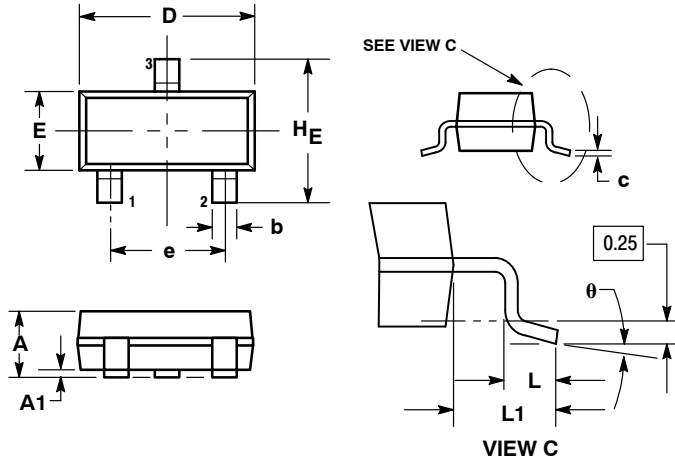


Figure 11. Gate Triggering Voltage vs.  $T_J$

# NYC0102BLT1G

## PACKAGE DIMENSIONS

SOT-23 (TO-236)  
CASE 318-08  
ISSUE AN



NOTES:

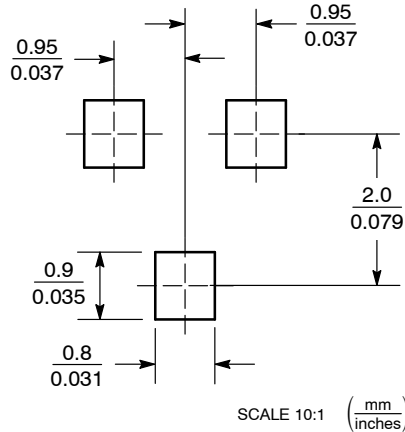
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. 318-01 THRU -07 AND -09 OBSOLETE, NEW STANDARD 318-08.

DIM	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
c	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
e	1.78	1.90	2.04	0.070	0.075	0.081
L	0.10	0.20	0.30	0.004	0.008	0.012
L1	0.35	0.54	0.69	0.014	0.021	0.029
HE	2.10	2.40	2.64	0.083	0.094	0.104

STYLE 8:

1. ANODE
2. NO CONNECTION
3. CATHODE

### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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